

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit	Page 1 of 1	
Xiuqin Sun		2863		

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*	B	US-6,477,438	11-2002	Sakai et al.	700/97
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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